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FQA7N60



## **FQA7N60 600V N-Channel MOSFET**

#### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

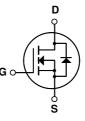
#### **Features**

+ 7.7A, 600V,  $R_{DS(on)}$  = 1.0 $\Omega$  @V<sub>GS</sub> = 10 V + Low gate charge ( typical 29 nC)

April 2000

FET™

- Low Crss (typical 16 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- TO-3P GDS FQA Series



## Absolute Maximum Ratings $T_{c} = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQA7N60	Units
V <sub>DSS</sub>	Drain-Source Voltage		600	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	C)	7.7	Α
	- Continuous (T <sub>C</sub> = 100°C)		4.8	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	30.8	А
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	580	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	7.7	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	15.2	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
PD	Power Dissipation (T <sub>C</sub> = 25°C) - Derate above 25°C		152	W
			1.22	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
ΤL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.82	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24		°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	600			V
ΔΒV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$ , Referenced to 25°C	;	0.67		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			10	μA
		V <sub>DS</sub> = 480 V, T <sub>C</sub> = 125°C			100	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.9 \text{ A}$		0.8	1.0	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 3.9 \text{ A}$ (Note 4		6.5		S
	ic Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		1100	1430	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		135	175	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			16	21	pF
Switch	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 300 V, I <sub>D</sub> = 7.4 A,		30	70	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 7.4 \text{ A},$ R <sub>G</sub> = 25 Ω		80	170	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			65	140	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5	i)	60	130	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 480 V, I <sub>D</sub> = 7.4 A,		29	38	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		7		nC
Q <sub>ad</sub>	Gate-Drain Charge	(Note 4, 5	j)	14.5		nC

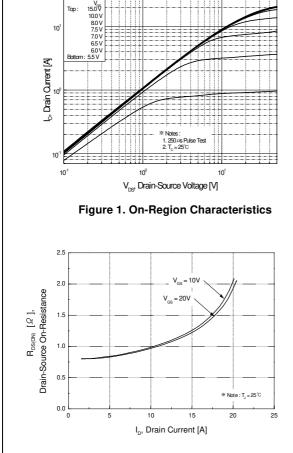
۱ <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				7.7	A
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				30.8	А
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 7.7 A			1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 V, I_S = 7.4 A,$		320		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)		2.4		μC

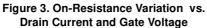
**Notes:** 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 18mH, I<sub>AS</sub> = 7.7A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25  $\Omega$ , Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub> = 7.4A, di/dt  $\leq 200A\mu$ s, V<sub>DD</sub>  $\leq 8V_{DSS}$  Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width  $\leq 300\mu$ s, Duty cycle  $\leq 2\%$ 5. Essentially independent of operating temperature

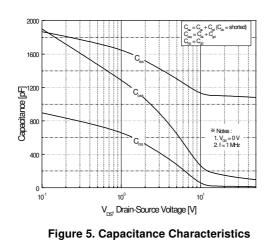
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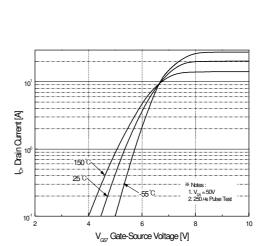


## **Typical Characteristics**

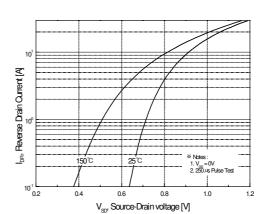


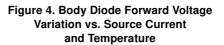


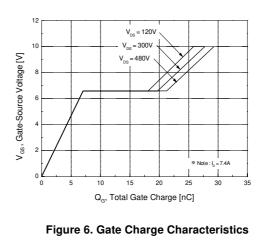






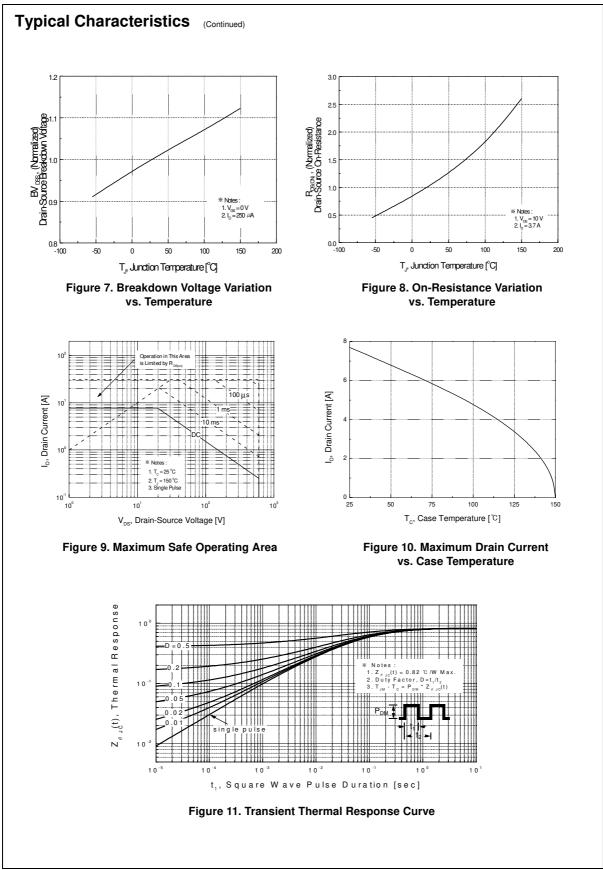




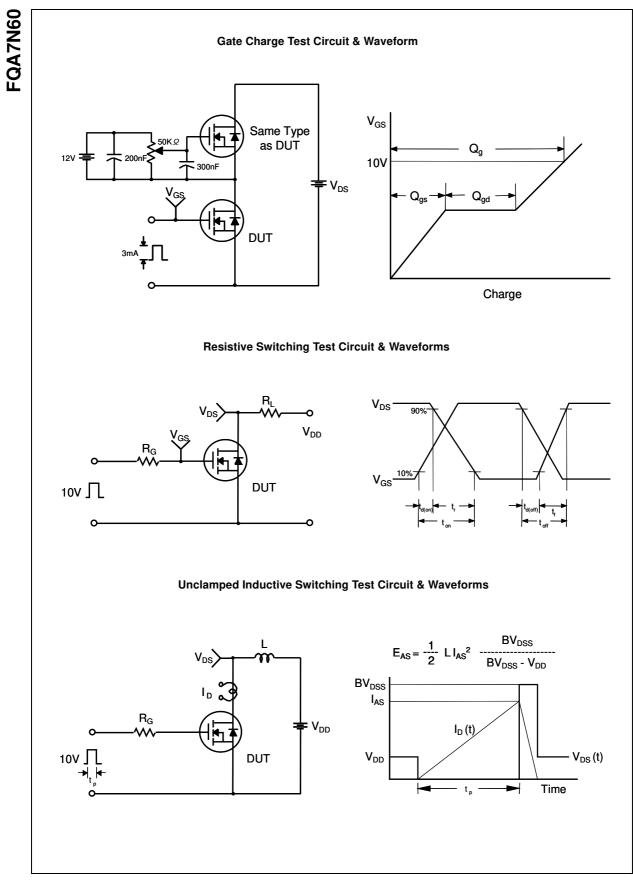




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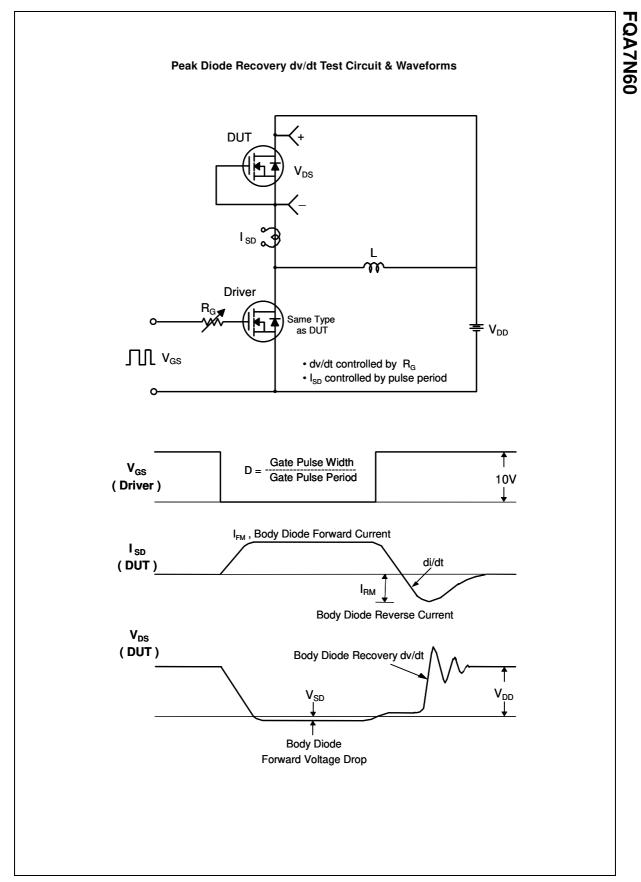


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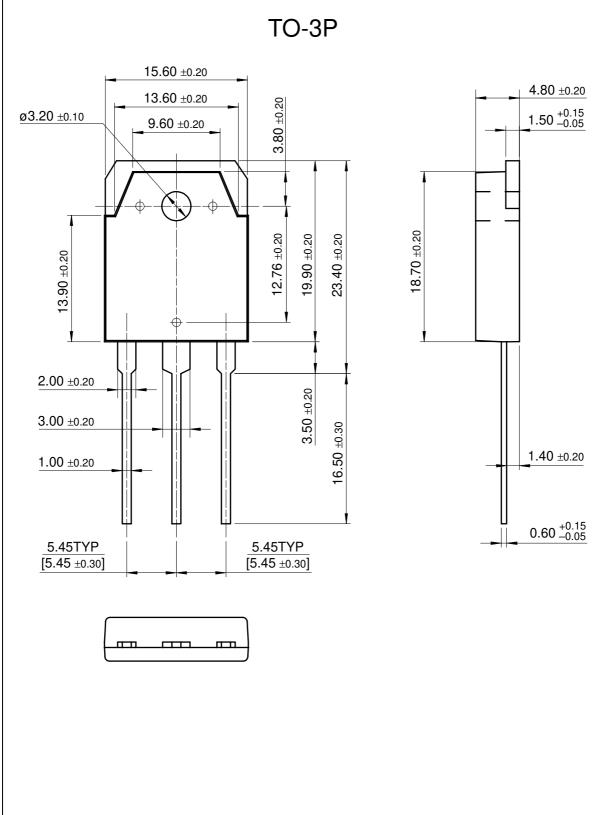


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#### Package Dimensions



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